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June 2001

FDT458P

AIRCHILE

SEMICONDUCTOR IM

FDT458P

30V P-Channel PowerTrench[®] MOSFET

General Description

This P-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers, and battery chargers.

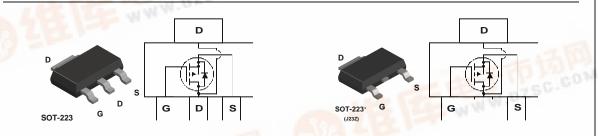
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable R_{DS(ON)} specifications.

Applications

- Battery chargers
- Motor drives

Features

- 3.4 A, -30 V. $R_{DS(ON)} = 130 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 200 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Fast switching speed
- Low gate charge (2.5 nC typical)
- High performance trench technology for extremely
 low R_{DS(ON)}
- High power and current handling capability in a widely used surface mount package



Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter D			Ratings	Units	
V _{DSS}	Drain-Source Voltage			- 30	V	
V _{GSS}	Gate-Source Voltage			±20	V	
l _D	Drain Currer	nt – Continuous	(Note 1a)	3.4	А	
		 Pulsed 		10	- 5	
PD	Maximum Power Dissipation		(Note 1a)	3.0	W	
			(Note 1b)	1.3	075C-0	
			(Note 1c)	1.1	44	
T_J, T_{STG}	Operating a	Dperating and Storage Junction Temperature Range		-55 to +150	°C	
Therma	I Charact	eristics				
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)		42	°C/W		
R _{ejc}	Thermal Resistance, Junction-to-Case (Note 1)			12		
Packag	e Marking	g and Ordering	g Information		·	
Device Marking		Device	Reel Size	Tape width	Quantity	
458P		FDT458P	13"	12mm	2500 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			1		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_D = -250 \mu A$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		-23		mV/ºC
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA
GSSF	Gate–Body Leakage, Forward	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)	·		•	•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-1	-1.8	-3	V
<u>ΔVgs(th)</u> ΔTj	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		4		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance			105 157 147	130 200 210	mΩ
D(on)	On–State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	-5			А
g _{FS}	Forward Transconductance	$V_{DS} = -5 V$, $I_{D} = -3.4 A$	-	3		S
-	Characteristics				l	
Ciss	Input Capacitance $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$			205		pF
Coss	Output Capacitance	f = 1.0 MHz		55		pF
Crss	Reverse Transfer Capacitance			26		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = -15 V$, $I_D = -1 A$,		4.5	9	ns
tr	Turn–On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$		12.5	23	ns
t _{d(off)}	Turn–Off Delay Time			11	20	ns
t _f	Turn–Off Fall Time			2	4	ns
Qg	Total Gate Charge	$V_{DS} = -15 V$, $I_D = -3.4 A$,		2.5	3.5	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -10 \text{ V}$		0.7		nC
Q _{gd}	Gate-Drain Charge]		1		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	Diode Forward Current			-2.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = -2.5 A$ (Note 2)		-0.8	-1.2	V

 R_{0.0} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0.0} is guaranteed by design while R_{0CA} is determined by the user's board design.



 a) 42°C/W when mounted on a 1in² pad of 2 oz copper

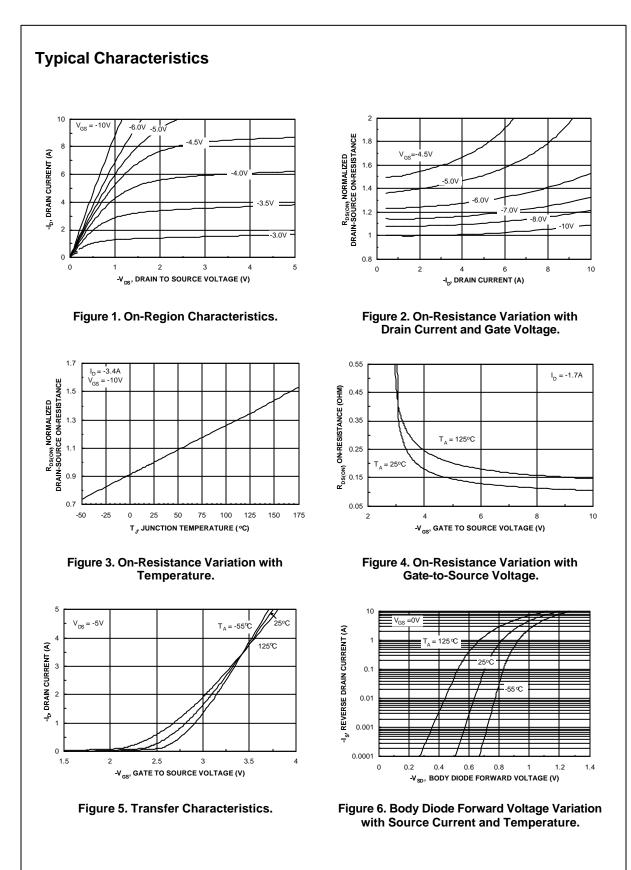
2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%



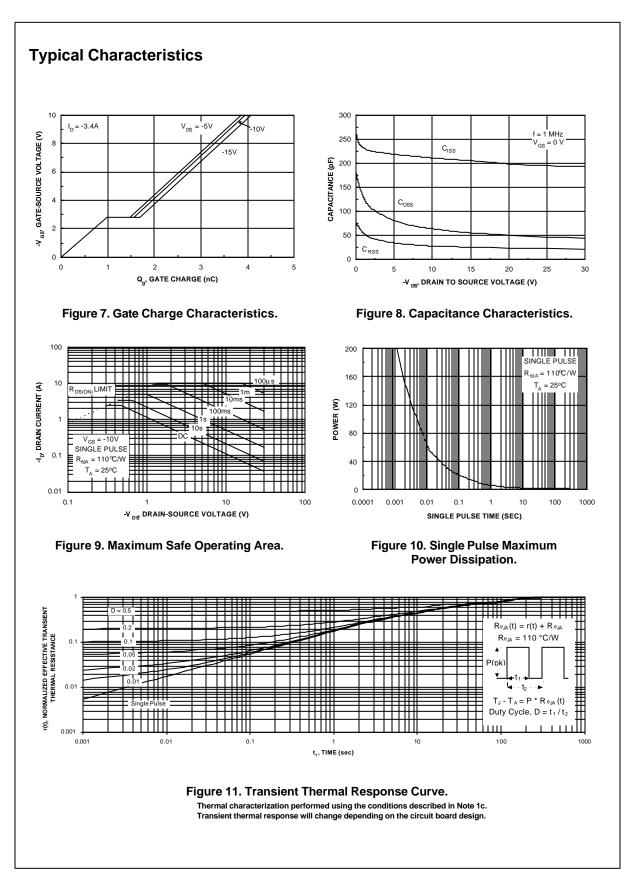
b) 95°C/W when mounted on a .0066 in² pad of 2 oz copper Ľ JJJ

c) 110°C/W when mounted on a minimum pad.

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